

# IEEE Guide for Conducting Distribution Impact Studies for Distributed Resource Interconnection

IEEE Standards Coordinating Committee 21

Sponsored by the  
IEEE Standards Coordinating Committee 21 on  
Fuel Cells, Photovoltaics, Dispersed Generation, and Energy Storage



# IEEE Guide for Conducting Distribution Impact Studies for Distributed Resource Interconnection

Sponsor

**IEEE Standards Coordinating Committee 21**

of the

**IEEE Standards Coordinating Committee 21 on Fuel Cells, Photovoltaics, Dispersed Generation, and Energy Storage**

Approved 11 December 2013

**IEEE-SA Standards Board**

**Abstract:** IEEE Std 1547.7™ is part of the IEEE 1547™ series of standards. Whereas IEEE Std 1547™-2003 provides mandatory requirements for the interconnection of distributed resources (DR) with electric power systems (EPS), this guide does not presume the interconnection is IEEE 1547™ compliant. Further, this guide does not interpret IEEE Std 1547™ or other standards in the IEEE 1547™ series, and this guide does not provide additional requirements or recommended practices related to the other IEEE 1547™ documents. However, DR interconnection may contribute to resultant conditions that could exceed what was normally planned for and built into the distribution system. This guide provides alternative approaches and good practices for engineering studies of the potential impacts of a DR or aggregate DR interconnected to the electric power distribution system. This guide describes criteria, scope, and extent for those engineering studies. Study scope and extent are described as functions of identifiable characteristics of the DR, the EPS, and the interconnection. The intent includes promoting impact study consistency while helping identify only those studies that should be performed based on technically transparent criteria for the DR interconnection.

**Keywords:** distributed energy resources, distributed generation, distributed power, distributed resources, distribution grid, distribution system, electric power systems, energy storage, federal utility grid, fuel cells, grid interconnection requirements and specifications, IEEE 1547.7™, interconnection, microturbines, national, photovoltaic power systems, public utility commission, regulations, renewable energy, rulemaking, regional, utility grid, utility grid dispersed generation

---

The Institute of Electrical and Electronics Engineers, Inc.  
3 Park Avenue, New York, NY 10016-5997, USA

Copyright © 2014 by The Institute of Electrical and Electronics Engineers, Inc.  
All rights reserved. Published 28 February 2014. Printed in the United States of America.

IEEE is a registered trademark in the U.S. Patent & Trademark Office, owned by The Institute of Electrical and Electronics Engineers, Incorporated.

PDF: ISBN 978-0-7381-8872-0      STD98508  
Print: ISBN 978-0-7381-8873-7      STDPD98508

*IEEE prohibits discrimination, harassment, and bullying.*

For more information, visit <http://www.ieee.org/web/aboutus/whatis/policies/p9-26.html>.

*No part of this publication may be reproduced in any form, in an electronic retrieval system or otherwise, without the prior written permission of the publisher.*

## **Important Notices and Disclaimers Concerning IEEE Standards Documents**

IEEE documents are made available for use subject to important notices and legal disclaimers. These notices and disclaimers, or a reference to this page, appear in all standards and may be found under the heading “Important Notice” or “Important Notices and Disclaimers Concerning IEEE Standards Documents.”

### **Notice and Disclaimer of Liability Concerning the Use of IEEE Standards Documents**

IEEE Standards documents (standards, recommended practices, and guides), both full-use and trial-use, are developed within IEEE Societies and the Standards Coordinating Committees of the IEEE Standards Association (“IEEE-SA”) Standards Board. IEEE (“the Institute”) develops its standards through a consensus development process, approved by the American National Standards Institute (“ANSI”), which brings together volunteers representing varied viewpoints and interests to achieve the final product. Volunteers are not necessarily members of the Institute and participate without compensation from IEEE. While IEEE administers the process and establishes rules to promote fairness in the consensus development process, IEEE does not independently evaluate, test, or verify the accuracy of any of the information or the soundness of any judgments contained in its standards.

IEEE does not warrant or represent the accuracy or content of the material contained in its standards, and expressly disclaims all warranties (express, implied and statutory) not included in this or any other document relating to the standard, including, but not limited to, the warranties of: merchantability; fitness for a particular purpose; non-infringement; and quality, accuracy, effectiveness, currency, or completeness of material. In addition, IEEE disclaims any and all conditions relating to: results; and workmanlike effort. IEEE standards documents are supplied “AS IS” and “WITH ALL FAULTS.”

Use of an IEEE standard is wholly voluntary. The existence of an IEEE standard does not imply that there are no other ways to produce, test, measure, purchase, market, or provide other goods and services related to the scope of the IEEE standard. Furthermore, the viewpoint expressed at the time a standard is approved and issued is subject to change brought about through developments in the state of the art and comments received from users of the standard.

In publishing and making its standards available, IEEE is not suggesting or rendering professional or other services for, or on behalf of, any person or entity nor is IEEE undertaking to perform any duty owed by any other person or entity to another. Any person utilizing any IEEE Standards document, should rely upon his or her own independent judgment in the exercise of reasonable care in any given circumstances or, as appropriate, seek the advice of a competent professional in determining the appropriateness of a given IEEE standard.

IN NO EVENT SHALL IEEE BE LIABLE FOR ANY DIRECT, INDIRECT, INCIDENTAL, SPECIAL, EXEMPLARY, OR CONSEQUENTIAL DAMAGES (INCLUDING, BUT NOT LIMITED TO: PROCUREMENT OF SUBSTITUTE GOODS OR SERVICES; LOSS OF USE, DATA, OR PROFITS; OR BUSINESS INTERRUPTION) HOWEVER CAUSED AND ON ANY THEORY OF LIABILITY, WHETHER IN CONTRACT, STRICT LIABILITY, OR TORT (INCLUDING NEGLIGENCE OR OTHERWISE) ARISING IN ANY WAY OUT OF THE PUBLICATION, USE OF, OR RELIANCE UPON ANY STANDARD, EVEN IF ADVISED OF THE POSSIBILITY OF SUCH DAMAGE AND REGARDLESS OF WHETHER SUCH DAMAGE WAS FORESEEABLE.

### **Translations**

The IEEE consensus development process involves the review of documents in English only. In the event that an IEEE standard is translated, only the English version published by IEEE should be considered the approved IEEE standard.

## **Official statements**

A statement, written or oral, that is not processed in accordance with the IEEE-SA Standards Board Operations Manual shall not be considered or inferred to be the official position of IEEE or any of its committees and shall not be considered to be, or be relied upon as, a formal position of IEEE. At lectures, symposia, seminars, or educational courses, an individual presenting information on IEEE standards shall make it clear that his or her views should be considered the personal views of that individual rather than the formal position of IEEE.

## **Comments on standards**

Comments for revision of IEEE Standards documents are welcome from any interested party, regardless of membership affiliation with IEEE. However, IEEE does not provide consulting information or advice pertaining to IEEE Standards documents. Suggestions for changes in documents should be in the form of a proposed change of text, together with appropriate supporting comments. Since IEEE standards represent a consensus of concerned interests, it is important that any responses to comments and questions also receive the concurrence of a balance of interests. For this reason, IEEE and the members of its societies and Standards Coordinating Committees are not able to provide an instant response to comments or questions except in those cases where the matter has previously been addressed. For the same reason, IEEE does not respond to interpretation requests. Any person who would like to participate in revisions to an IEEE standard is welcome to join the relevant IEEE working group.

Comments on standards should be submitted to the following address:

Secretary, IEEE-SA Standards Board  
445 Hoes Lane  
Piscataway, NJ 08854 USA

## **Laws and regulations**

Users of IEEE Standards documents should consult all applicable laws and regulations. Compliance with the provisions of any IEEE Standards document does not imply compliance to any applicable regulatory requirements. Implementers of the standard are responsible for observing or referring to the applicable regulatory requirements. IEEE does not, by the publication of its standards, intend to urge action that is not in compliance with applicable laws, and these documents may not be construed as doing so.

## **Copyrights**

IEEE draft and approved standards are copyrighted by IEEE under U.S. and international copyright laws. They are made available by IEEE and are adopted for a wide variety of both public and private uses. These include both use, by reference, in laws and regulations, and use in private self-regulation, standardization, and the promotion of engineering practices and methods. By making these documents available for use and adoption by public authorities and private users, IEEE does not waive any rights in copyright to the documents.

## **Photocopies**

Subject to payment of the appropriate fee, IEEE will grant users a limited, non-exclusive license to photocopy portions of any individual standard for company or organizational internal use or individual, non-commercial use only. To arrange for payment of licensing fees, please contact Copyright Clearance Center, Customer Service, 222 Rosewood Drive, Danvers, MA 01923 USA; +1 978 750 8400. Permission to photocopy portions of any individual standard for educational classroom use can also be obtained through the Copyright Clearance Center.

## Updating of IEEE Standards documents

Users of IEEE Standards documents should be aware that these documents may be superseded at any time by the issuance of new editions or may be amended from time to time through the issuance of amendments, corrigenda, or errata. An official IEEE document at any point in time consists of the current edition of the document together with any amendments, corrigenda, or errata then in effect.

Every IEEE standard is subjected to review at least every ten years. When a document is more than ten years old and has not undergone a revision process, it is reasonable to conclude that its contents, although still of some value, do not wholly reflect the present state of the art. Users are cautioned to check to determine that they have the latest edition of any IEEE standard.

In order to determine whether a given document is the current edition and whether it has been amended through the issuance of amendments, corrigenda, or errata, visit the IEEE-SA Website at <http://ieeexplore.ieee.org/xpl/standards.jsp> or contact IEEE at the address listed previously. For more information about the IEEE-SA or IEEE's standards development process, visit the IEEE-SA Website at <http://standards.ieee.org>.

## Errata

Errata, if any, for all IEEE standards can be accessed on the IEEE-SA Website at the following URL: <http://standards.ieee.org/findstds/errata/index.html>. Users are encouraged to check this URL for errata periodically.

## Patents

Attention is called to the possibility that implementation of this standard may require use of subject matter covered by patent rights. By publication of this standard, no position is taken by the IEEE with respect to the existence or validity of any patent rights in connection therewith. If a patent holder or patent applicant has filed a statement of assurance via an Accepted Letter of Assurance, then the statement is listed on the IEEE-SA Website at <http://standards.ieee.org/about/sasb/patcom/patents.html>. Letters of Assurance may indicate whether the Submitter is willing or unwilling to grant licenses under patent rights without compensation or under reasonable rates, with reasonable terms and conditions that are demonstrably free of any unfair discrimination to applicants desiring to obtain such licenses.

Essential Patent Claims may exist for which a Letter of Assurance has not been received. The IEEE is not responsible for identifying Essential Patent Claims for which a license may be required, for conducting inquiries into the legal validity or scope of Patents Claims, or determining whether any licensing terms or conditions provided in connection with submission of a Letter of Assurance, if any, or in any licensing agreements are reasonable or non-discriminatory. Users of this standard are expressly advised that determination of the validity of any patent rights, and the risk of infringement of such rights, is entirely their own responsibility. Further information may be obtained from the IEEE Standards Association.

## Participants

At the time this IEEE guide was completed, the DRIS Working Group had the following membership:

**Robert Saint, *Chair***  
**Thomas Basso, *Secretary***

Rasool Aghatehrani	John Foster	Rafael Nielson
Marcelo Algrain	Joe Fox	John Nunneley
Muhammed Ali	John Gajda	Gary Olson
Wendy Al-Mukdad	Harjects Gill	Marc Patterson
Robert Arritt	Joerg Grosshennig	David Pearce
Adil Aziz	Jason Gunawardena	Mark Pokryska
Martin Baier	Jianlin Guo	James Reilly
Mark Baldassari	Joshua Hambrick	Roy Riety
David Bassett	Keith Harley	D. Tom Rizy
David Beach	Patrick Healey	Roger Salas
Weruir Blumer	Taylor Hollis	Daniel Sammon
David Bosack	Soonwook Hong	Colin Schauder
Ryan Boudreau	Iran Iqbal	Karl Schoder
James Bridges	Hiroshi Irie	Brian Seal
Robert Broadwater	Stoli Jager	Paul Sheaffer
Drazena Brocilo	Lu Jiang	Michael Sheehan
Ken Brunkenhoefer	Gerald Johnson	Mark Siira
Yi Chen	Hal Kamigaki	Mark Smith
Christopher Clarke	Farid Katiraei	Gary Smullin
James Cleary	Maeda Kazuto	Farajollah Soudi
Michael Coddington	David Kelley	Jim Sprecher
Nancy Connelly	Joseph L. Koepfinger	Wayne Stec
Marv Dagatz	Connie Komomua	Chase Sun
Subir Das	James Lemke	Tzen Woo Tham
Herbert Daugherty	Claudio Lima	Michael Thesing
Richard DeBlasio	Brian Lydic	Scott Thomas
Mamadou Diong	Hitoshi Maejima	Sylvester Toe
Jose Dizon	Nokhum Markusevich	Brandon Tolentino
Dale Donovan	Anthony Mazy	Phuoc Tran
Michael Doyle	Tom McDermott	Philippe Venne
Robert Eastham	Charles Mee	Simon Wall
Peter Evans	Bill Moncrief	Reigh Walling
Masoud Farivar	Zinn Morton	Keith Walters
David Farmer	George Moskos	Allen Windhom
Omar Faruque	Arun Narang	Nicolas Wrathall
Markus Fischer	David Nichols	Timothy Zgonena
Rhys Foster		Michael Zuercher-Martinson

At the time this draft guide was completed, SCC21 had the following membership:

**Richard DeBlasio, *Chair***  
**Thomas Basso, *Vice Chair and Secretary***

David Bassett	Kelvin Hecht	Peter McNutt
Paul Bishop	Yiming Hou	Thomas Prevost
John Bzura	Gerald Johnson	Charles Rogers
James M. Daley	Joseph L. Koepfinger	Robert Saint
Douglas C. Dawson	Benjamin Kroposki	Mark Siira
Frank Goodman		Timothy Zgonena



The following members of the individual balloting committee voted on this guide. Balloters may have voted for approval, disapproval, or abstention.

Mohamed Abdel Khalek	Keith Harley	Alvaro Portillo
William Ackerman	J. Harlow	Daniel Leland Ransom
Steven Alexanderson	Jeffrey Hauber	James Reilly
Marcelo Algrain	Patrick Healey	Robert Robinson
Jay Anderson	Werner Hoelzl	Charles Rogers
Martin Baier	Robert Hoerauf	Ken Romano
Mark Baldassari	Jerry Hohn	John Rossetti
G. Bartok	Soonwook Hong	D. Daniel Sabin
David Bassett	Joseph Jancauskas	Robert Saint
Kenneth Behrendt	Brian Johnson	Chester Sandberg
Wallace Binder	Gerald Johnson	Steven Sano
William Bloethe	Innocent Kamwa	Bartien Sayogo
David Bosack	Gael Kennedy	Karl Schoder
Ryan Boudreau	Yuri Khersonsky	Thomas Schossig
James Bouford	Morteza Khodaie	Samuel Sciacca
James Bougie	James Kinney	Robert Seitz
Chris Brooks	Boris Kogan	Paul Sheaffer
David Brown	Ljubomir Kojovic	Mark Siira
Gustavo Brunello	Benjamin Kroposki	Amy Sinclair
William Byrd	Jim Kulchisky	Herbert Sinnock
Paul Cardinal	Chung-Yiu Lam	Jerry Smith
Keith Chow	Raluca Lascu	Gary Smullin
James Cleary	Kevin Little	John Spare
James Cole	Omar Mazzoni	Thomas Starai
Larry Conrad	John McDaniel	Wayne Stec
Stephen Conrad	John McDonald	Michael Stelts
Terry Conrad	Hank McGlynn	Gary Stoedter
Garth Corey	Dean Miller	Charles Sufana
Luis Coronado	John Miller	James Swank
Randall Crellin	William Moncrief	John Tengdin
Randall Cunico	Jose Morales	David Tepen
Matthew Davis	Kimberly Mosley	James Timperley
Kevin Donahoe	Daniel Mulkey	Elisabeth Tobin
Carlo Donaati	Daniel Mungovan	Sylvester Toe
Neal Dowling	Jerry Murphy	Demetrios Tziouvaras
Michael Doyle	Mangapathirao Mynam	Joe Uchiyama
Ahmed Elneweihi	Arun Narang	Eric Udren
Brian Escott	Michael Newman	John Vergis
Dan Evans	Charles Ngethe	Jane Vemer
David Farmer	David Nichols	Simon Wall
Omar Faruque	Nick S. A. Nikjoo	Reigh Walling
Rostyslaw Fostiak	Joe Nims	John Wang
Fredric Friend	Matthew Norwalk	Daniel Ward
Doaa Galal	Lorraine Padden	J. Weber
Frank Gerleve	Mirko Palazzo	Kenneth White
David Gilmer	Panagiotis Papadopoulos	Nicolas Wrathall
J. T. Gordon	Bansi Patel	Robert Yinger
Stephen Grier	Subhash Patel	James Zieberth
Randall Groves	Marc Patterson	Sergio Zimath
Donald Hall	Christopher Petrola	Michael Zuercher-Martinson
	Dean Philips	

When the IEEE-SA Standards Board approved this guide on 11 December 2013, it had the following membership:

**John Kulick**, *Chair*  
**David J. Law**, *Vice Chair*  
**Richard H. Hulett**, *Past Chair*  
**Konstantinos Karachalios**, *Secretary*

Masayuki Ariyoshi  
Peter Balma  
Farooq Bari  
Ted Burse  
Stephen Dukes  
Jean-Philippe Faure  
Alexander Gelman

Mark Halpin  
Gary Hoffman  
Paul Houzé  
Jim Hughes  
Michael Janezic  
Joseph L. Koepfinger\*  
Oleg Logvinov  
Ron Petersen

Gary Robinson  
Jon Walter Rosdahl  
Adrian Stephens  
Peter Sutherland  
Yatin Trivedi  
Phil Winston  
Yu Yuan

\*Member Emeritus

Also included are the following nonvoting IEEE-SA Standards Board liaisons:

Richard DeBlasio, *DOE Representative*  
Michael Janezic, *NIST Representative*

Julie Alessi  
*IEEE-SA Content Publishing*

Soo H. Kim  
*IEEE-SA Technical Community Programs*

## Introduction

This introduction is not part of IEEE Std 1547.7™-2013, IEEE Guide for Conducting Distribution Impact Studies for Distributed Resource Interconnection.

With the advent of IEEE Std 1547™-2003, modern interconnection equipment has made great gains by having universal interconnection and test requirements focused at the point of common coupling. Additionally, since the adoption of IEEE Std 1547™, there has been significant experience gained related to inter-related technology systems and operational concepts to properly integrate distributed resources (DR) into electric power systems (EPS). Traditionally, however, utility electric power systems were not designed to accommodate active generation and storage at the distribution level. The addition of DR to an EPS will change the system and its response in some manner. Increased adoption of distributed resources throughout distribution systems often results in the need to perform a distribution system impact study. This guide provides a common technical platform based on engineering knowledge to address study methods for performing DR-EPS impact studies. This document includes an overview of general considerations, operational considerations, configuration considerations, preliminary review criteria, conventional and special impact studies methodologies, tools and technical issues, data requirements, and examples of mitigation techniques. A sample methodology for using the guide is also provided. The intended audience will gain a common technical understanding as well as an increased understanding of the potential impacts of DR interconnection. The guide addresses engineering studies from a technical perspective rather than a regulatory perspective. This document establishes guidance including multiple approaches (alternatives/choices) using engineering studies based on engineering best practices, including engineering characteristics, engineering studies methodologies, and engineering parameter criteria to understand and use the engineering studies results.

## Contents

1. Overview .....	1
1.1 Scope .....	1
1.2 Purpose .....	1
1.3 Intended audience .....	2
1.4 Limitations .....	2
1.5 Document structure .....	3
2. Normative references .....	4
3. Definitions .....	4
3.1 Definitions .....	4
3.2 Acronyms and abbreviations .....	4
4. General considerations for DR impact studies .....	6
4.1 Potential DR impacts on the Area EPS .....	7
4.2 DR primary energy source-related considerations .....	9
4.3 DR technology-specific considerations .....	10
4.4 Area EPS-related considerations .....	11
5. Operational and configuration considerations .....	13
5.1 DR attributes affecting interconnection .....	13
5.2 Area EPS attributes affecting interconnection .....	27
6. System impact example methodology .....	33
7. Preliminary review criteria and sub-criteria .....	34
7.1 Introduction .....	34
7.2 Criteria ID P1—Use of certified DR equipment .....	37
7.3 Criteria ID P2—Potential for unintended islands .....	39
7.4 Criteria ID P3—Impact on EPS equipment loading under all steady state conditions .....	43
7.5 Criteria ID P4—Impacts on system protection, fault conditions, and arc flash rating .....	45
7.6 Criteria ID P5—Impacts on voltage regulation within the EPS under steady state conditions .....	51
7.7 Criteria ID P6—Impacts on EPS power quality .....	57
8. Conventional distribution studies .....	60
8.1 Introduction .....	60
8.2 Study ID C1—Steady state simulation .....	61
8.3 Study ID C2—System protection studies .....	63
8.4 Study ID C3—Operational characteristics—loading, load shedding, etc. ....	71
9. Special system impact studies .....	72
9.1 Introduction .....	72
9.2 Technical basis for the studies .....	73
9.3 Study methodologies .....	75
9.4 Study ID S1—Quasi-static simulation .....	77
9.5 Study ID S2—Dynamic simulation .....	77
9.6 Study ID S3—Electromagnetic transient simulation .....	80
9.7 Study ID S4—Harmonics and flicker .....	83
10. Data requirements .....	88
10.1 Data requirements and modeling for preliminary review studies .....	91

10.2 Data requirements for conventional studies.....	96
10.3 Data requirements for special studies .....	102
11. Impact mitigation overview.....	105
11.1 Potential solutions for unintended islands upon separation from the greater Area EPS .....	105
11.2 Potential solutions for impacts on EPS equipment loading under all steady state conditions in violation of requirements.....	107
11.3 Potential solutions for impacts on system protection and fault conditions in violation of requirements .....	107
11.4 Potential solutions for impacts on voltage regulation within the EPS under steady state conditions in violation of requirements.....	109
11.5 Potential solutions for impacts on power quality.....	112
Annex A (informative) Bibliography .....	114
Annex B (informative) Sample data for impact studies .....	116
B.1 Main grid data .....	116
B.2 Substation transformer data .....	116
B.3 Load tap changer and voltage regulator data .....	117
B.4 Circuit breaker and recloser data.....	117
B.5 Capacitor bank data.....	118
B.6 Feeder protection equipment data .....	118
B.7 Load data.....	118
B.8 Feeder (sections) data.....	119
B.9 DER data—rotating machine type .....	119
B.10 DR data—electronically coupled type .....	120
B.11 Solar PV inverters .....	120
B.12 Wind turbine inverters .....	121
B.13 Energy storage inverters.....	121
Annex C (informative) Glossary .....	123



# IEEE Guide for Conducting Distribution Impact Studies for Distributed Resource Interconnection

*IMPORTANT NOTICE: IEEE Standards documents are not intended to ensure safety, security, health, or environmental protection, or ensure against interference with or from other devices or networks. Implementers of IEEE Standards documents are responsible for determining and complying with all appropriate safety, security, environmental, health, and interference protection practices and all applicable laws and regulations.*

*This IEEE document is made available for use subject to important notices and legal disclaimers. These notices and disclaimers appear in all publications containing this document and may be found under the heading “Important Notice” or “Important Notices and Disclaimers Concerning IEEE Documents.” They can also be obtained on request from IEEE or viewed at <http://standards.ieee.org/IPR/disclaimers.html>.*

## 1. Overview

### 1.1 Scope

This guide describes criteria, scope, and extent for engineering studies of the impact on area electric power systems of a distributed resource (DR) or aggregate distributed resource interconnected to an area electric power distribution system.

### 1.2 Purpose

The creation of IEEE Std 1547<sup>TM</sup>-2003 has led to the increased adoption of DR throughout distribution systems.<sup>1,2</sup> This document describes a methodology for performing engineering studies of the potential impact of a DR interconnected to an area electric power distribution system. Study scope and extent are described as functions of identifiable characteristics of the DR, the area electric power system, and the interconnection. Criteria are described for determining the necessity of impact mitigation.

Establishment of this guide allows DR owners, interconnection contractors, area electric distribution power system owners and operators, and regulatory bodies to have a described methodology for when distribution

---

<sup>1</sup> IEEE publications are available from The Institute of Electrical and Electronics Engineers, 445 Hoes Lane, Piscataway, NJ 08854, USA (<http://standards.ieee.org/>).

<sup>2</sup> Information on references can be found in Clause 2.